Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/016,128	FARIES, ET AL.	
Examiner	Art Unit	
Michael J. Hayes	3767	

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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated search - see search history	10/31/2005	MJH	